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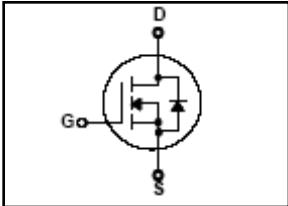
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## HFP830 500V N-Channel MOSFET

### FEATURES

- Originative New Design
- Superior Avalanche Rugged Technology
- Robust Gate Oxide Technology
- Very Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Unrivalled Gate Charge : 18 nC (Typ.)
- Extended Safe Operating Area
- Lower  $R_{DS(ON)}$  : 1.2 Ω (Typ.) @ $V_{GS}=10V$
- 100% Avalanche Tested

$BV_{DSS} = 500 V$   
 $R_{DS(on)\ typ} = 1.2 \Omega$   
 $I_D = 4.5 A$



### Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise specified

| Symbol         | Parameter                                                                     | Value       | Units         |
|----------------|-------------------------------------------------------------------------------|-------------|---------------|
| $V_{DSS}$      | Drain-Source Voltage                                                          | 500         | V             |
| $I_D$          | Drain Current – Continuous ( $T_C = 25^\circ C$ )                             | 4.5         | A             |
|                | Drain Current – Continuous ( $T_C = 100^\circ C$ )                            | 2.9         | A             |
| $I_{DM}$       | Drain Current – Pulsed (Note 1)                                               | 18          | A             |
| $V_{GS}$       | Gate-Source Voltage                                                           | $\pm 30$    | V             |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                                       | 270         | mJ            |
| $I_{AR}$       | Avalanche Current (Note 1)                                                    | 4.5         | A             |
| $E_{AR}$       | Repetitive Avalanche Energy (Note 1)                                          | 7.3         | mJ            |
| $dv/dt$        | Peak Diode Recovery $dv/dt$ (Note 3)                                          | 5.5         | V/ns          |
| $P_D$          | Power Dissipation ( $T_C = 25^\circ C$ )                                      | 73          | W             |
|                | – Derate above $25^\circ C$                                                   | 0.58        | W/ $^\circ C$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                       | -55 to +150 | $^\circ C$    |
| $T_L$          | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300         | $^\circ C$    |

### Thermal Resistance Characteristics

| Symbol          | Parameter           | Typ. | Max. | Units        |
|-----------------|---------------------|------|------|--------------|
| $R_{\theta JC}$ | Junction-to-Case    | --   | 1.71 | $^\circ C/W$ |
| $R_{\theta CS}$ | Case-to-Sink        | 0.5  | --   |              |
| $R_{\theta JA}$ | Junction-to-Ambient | --   | 62.5 |              |

**Electrical Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise specified

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**On Characteristics**

|                     |                                   |                                                  |     |     |     |          |
|---------------------|-----------------------------------|--------------------------------------------------|-----|-----|-----|----------|
| $V_{GS}$            | Gate Threshold Voltage            | $V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$      | 2.5 | --  | 4.5 | V        |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS} = 10 \text{ V}$ , $I_D = 2.25 \text{ A}$ | --  | 1.2 | 1.5 | $\Omega$ |

**Off Characteristics**

|                                |                                           |                                                            |     |      |      |                           |
|--------------------------------|-------------------------------------------|------------------------------------------------------------|-----|------|------|---------------------------|
| $BV_{DSS}$                     | Drain-Source Breakdown Voltage            | $V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$           | 500 | --   | --   | V                         |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$ | --  | 0.54 | --   | $\text{V}/^\circ\text{C}$ |
| $I_{DSS}$                      | Zero Gate Voltage Drain Current           | $V_{DS} = 500 \text{ V}$ , $V_{GS} = 0 \text{ V}$          | --  | --   | 1    | $\mu\text{A}$             |
|                                |                                           | $V_{DS} = 400 \text{ V}$ , $T_C = 125^\circ\text{C}$       | --  | --   | 10   | $\mu\text{A}$             |
| $I_{GSSF}$                     | Gate-Body Leakage Current, Forward        | $V_{GS} = 30 \text{ V}$ , $V_{DS} = 0 \text{ V}$           | --  | --   | 100  | nA                        |
| $I_{GSSR}$                     | Gate-Body Leakage Current, Reverse        | $V_{GS} = -30 \text{ V}$ , $V_{DS} = 0 \text{ V}$          | --  | --   | -100 | nA                        |

**Dynamic Characteristics**

|           |                              |                                                                             |    |     |     |    |
|-----------|------------------------------|-----------------------------------------------------------------------------|----|-----|-----|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ ,<br>$f = 1.0 \text{ MHz}$ | -- | 750 | 980 | pF |
| $C_{oss}$ | Output Capacitance           |                                                                             | -- | 80  | 105 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |                                                                             | -- | 11  | 14  | pF |

**Switching Characteristics**

|              |                     |                                                                                                 |    |     |     |    |
|--------------|---------------------|-------------------------------------------------------------------------------------------------|----|-----|-----|----|
| $t_{d(on)}$  | Turn-On Time        | $V_{DS} = 250 \text{ V}$ , $I_D = 4.5 \text{ A}$ ,<br>$R_G = 25 \Omega$<br><br>(Note 4,5)       | -- | 15  | 30  | ns |
| $t_r$        | Turn-On Rise Time   |                                                                                                 | -- | 40  | 80  | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |                                                                                                 | -- | 60  | 120 | ns |
| $t_f$        | Turn-Off Fall Time  |                                                                                                 | -- | 40  | 80  | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 400 \text{ V}$ , $I_D = 4.5 \text{ A}$ ,<br>$V_{GS} = 10 \text{ V}$<br><br>(Note 4,5) | -- | 18  | 23  | nC |
| $Q_{gs}$     | Gate-Source Charge  |                                                                                                 | -- | 3.9 | --  | nC |
| $Q_{gd}$     | Gate-Drain Charge   |                                                                                                 | -- | 7.5 | --  | nC |

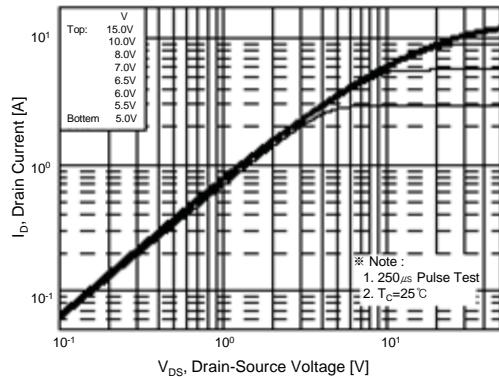
**Source-Drain Diode Maximum Ratings and Characteristics**

|          |                                               |                                                                                                  |    |     |     |               |
|----------|-----------------------------------------------|--------------------------------------------------------------------------------------------------|----|-----|-----|---------------|
| $I_S$    | Continuous Source-Drain Diode Forward Current | --                                                                                               | -- | 4.5 | A   |               |
| $I_{SM}$ | Pulsed Source-Drain Diode Forward Current     | --                                                                                               | -- | 18  |     |               |
| $V_{SD}$ | Source-Drain Diode Forward Voltage            | $I_S = 4.5 \text{ A}$ , $V_{GS} = 0 \text{ V}$                                                   | -- | --  | 1.4 | V             |
| $trr$    | Reverse Recovery Time                         | $I_S = 4.5 \text{ A}$ , $V_{GS} = 0 \text{ V}$<br>$dI_F/dt = 100 \text{ A}/\mu\text{s}$ (Note 4) | -- | 300 | --  | ns            |
| $Qrr$    | Reverse Recovery Charge                       |                                                                                                  | -- | 2.5 | --  | $\mu\text{C}$ |

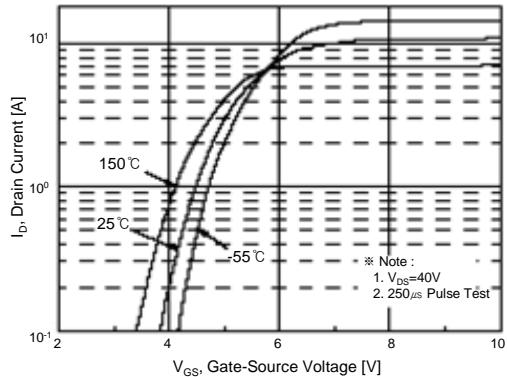
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $L=24\text{mH}$ ,  $I_{AS}=4.5\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- $I_{SD}\leq 4.5\text{A}$ ,  $di/dt\leq 300\text{A}/\mu\text{s}$ ,  $V_{DD}\leq BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

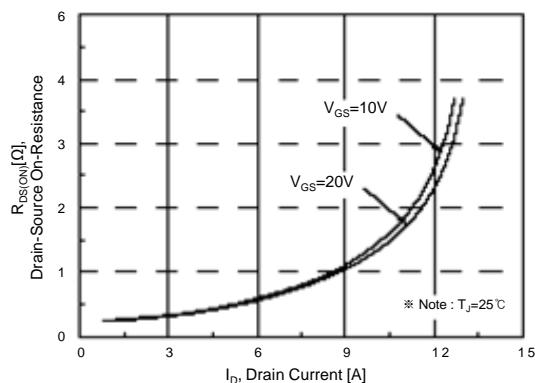
## Typical Characteristics



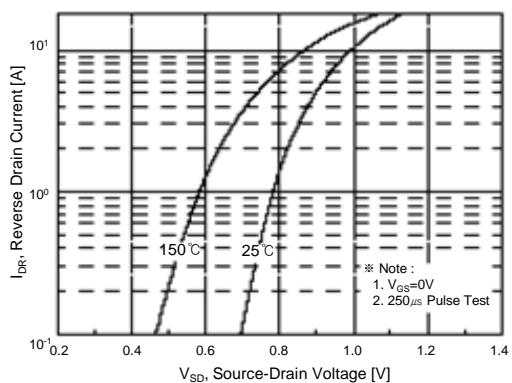
**Figure 1. On Region Characteristics**



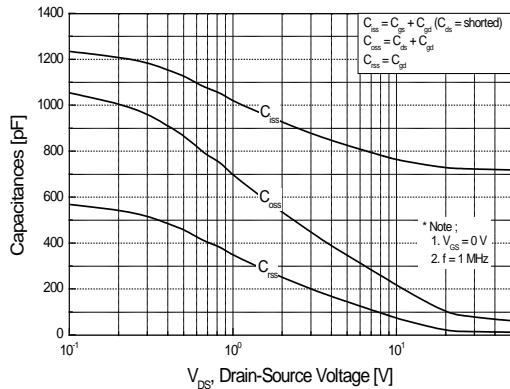
**Figure 2. Transfer Characteristics**



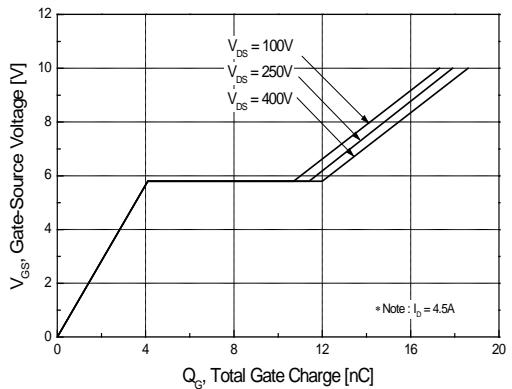
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

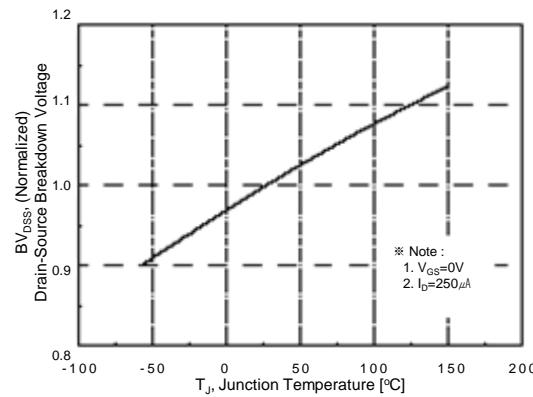


**Figure 5. Capacitance Characteristics**

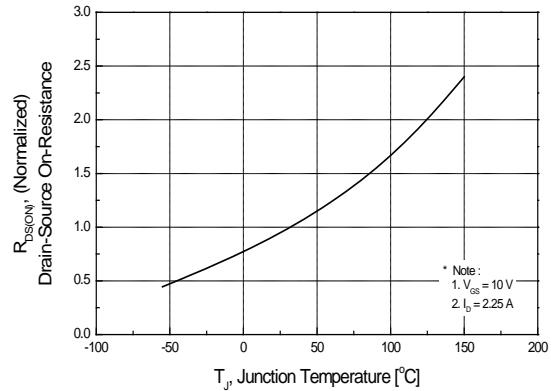


**Figure 6. Gate Charge Characteristics**

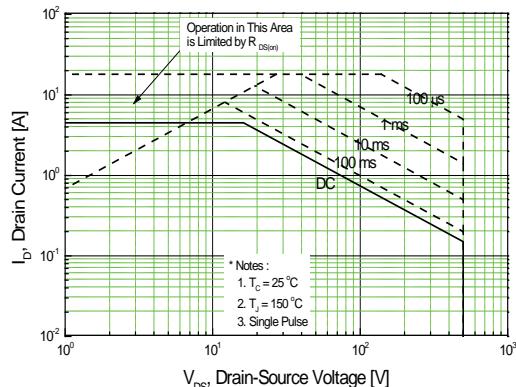
## Typical Characteristics (continued)



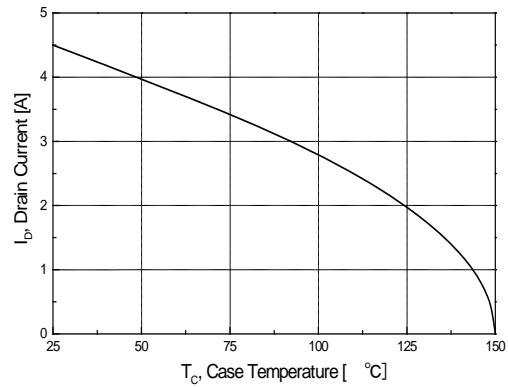
**Figure 7. Breakdown Voltage Variation vs Temperature**



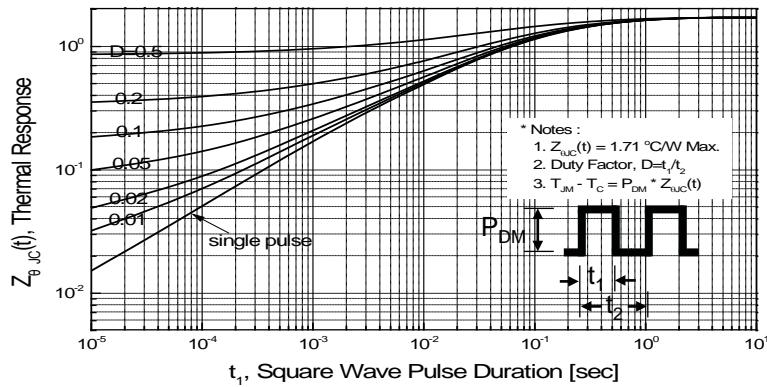
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

Fig 12. Gate Charge Test Circuit &amp; Waveform

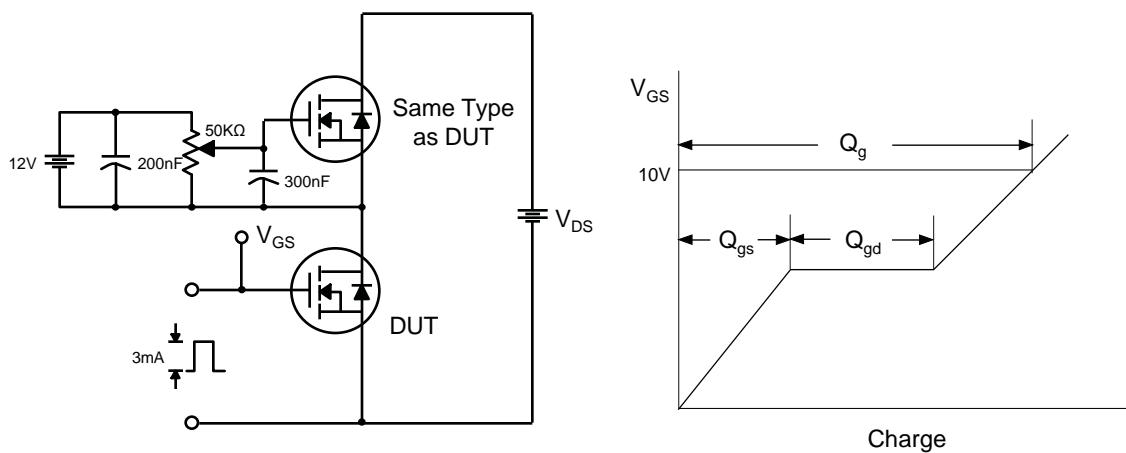


Fig 13. Resistive Switching Test Circuit &amp; Waveforms

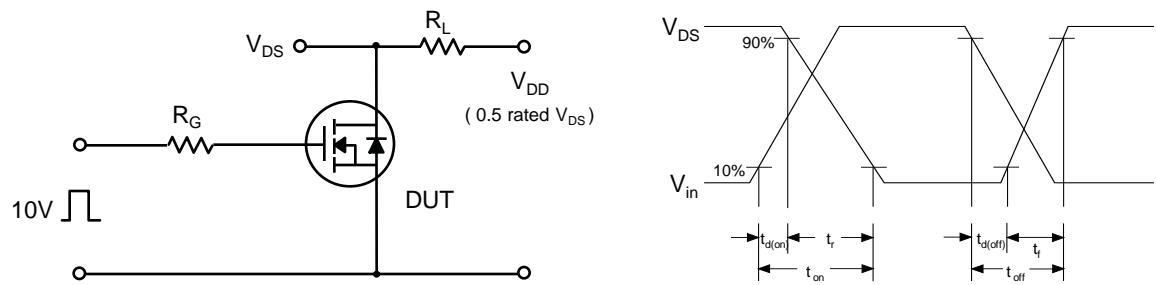


Fig 14. Unclamped Inductive Switching Test Circuit &amp; Waveforms

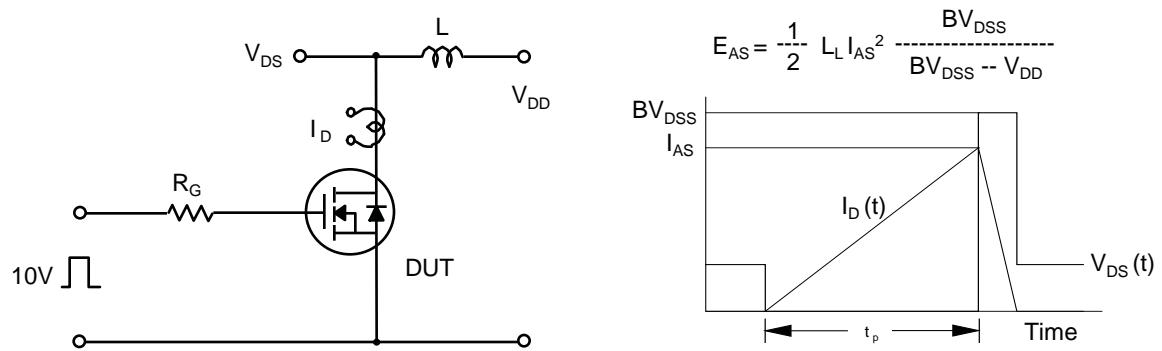
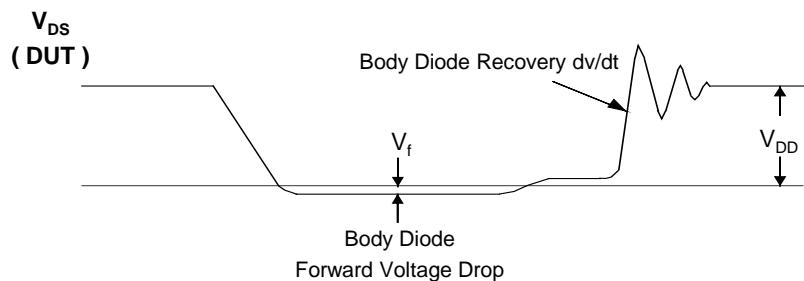
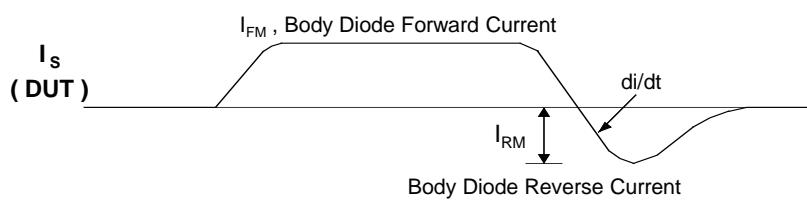
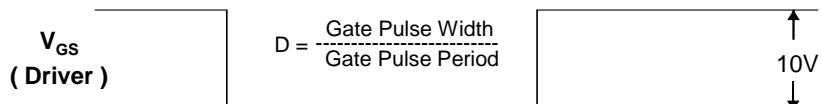
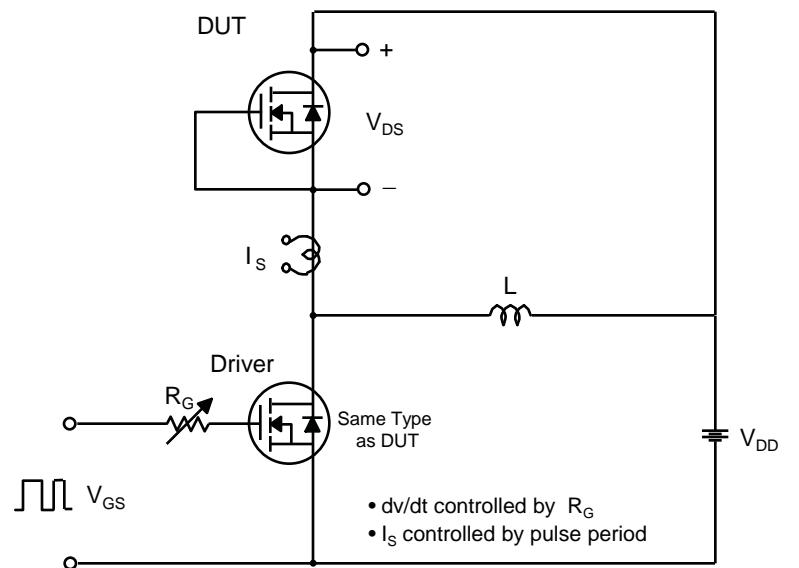
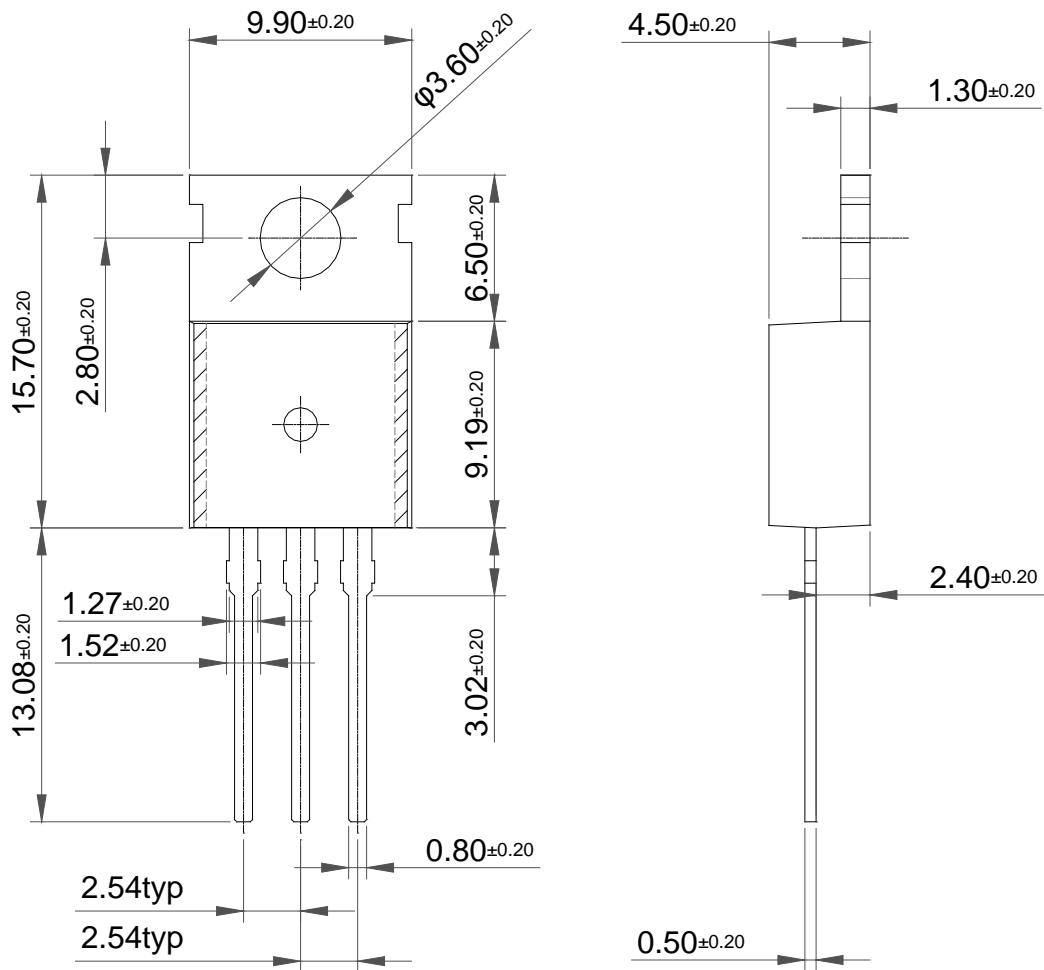


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



**Package Dimension****TO-220 (A)**

**TO-220 (B)**